

FL1006-VB Datasheet N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY	
V _{DS} (V)	30
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$	0.019
$R_{DS(on)}(\Omega)$ at $V_{GS} = 4.5 \text{ V}$	0.021
I _D (A)	7
Configuration	Single

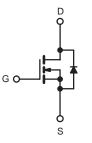
FEATURES

- Trench Power MOSFET
- \bullet 100 % R_g and UIS Tested









N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	(T _C = 25 °C, unles	s otherwise noted	d)		
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage	V _{DS}	30	.,		
Gate-Source Voltage		± 20	- V		
Ocalia de Bario Ocard	T _C = 25 °C	1	7		
Continuous Drain Current	T _C = 125 °C	- I _D	4.5		
Continuous Source Current (Diode Conductio	n)	Is	5	Α	
Pulsed Drain Current ^a		I _{DM}	31		
Single Pulse Avalanche Current	1 0.1 mll	I _{AS}	10		
Single Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	5	mJ	
Maximum Davies Dissination?	T _C = 25 °C	D	4	W	
Maximum Power Dissipation ^a	T _C = 125 °C	P_{D}	1.3	VV	
Operating Junction and Storage Temperature	Range	T _J , T _{stg}	- 55 to + 175	°C	

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount ^b	R_{thJA}	110	°C/W
Junction-to-Foot (Drain)		R_{thJF}	38	C/ VV

Notes

- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%.$
- b. When mounted on 1" square PCB (FR-4 material).
- c. Parametric verification ongoing.



SPECIFICATIONS ($T_C = 25 ^{\circ}C$, PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static	STIVIBOL	IES	IVIIIN.	ITF.	WAX.	ONII	
	V _{DS}	V	= 0 V, I _D = 250 μA	30	_		<u> </u>
Drain-Source Breakdown Voltage		V _{GS} = 0 v, η _D = 250 μA V _{DS} = V _{GS} , I _D = 250 μA		0.5		-	V
Gate-Source Threshold Voltage	V _{GS(th)}		$0 \text{ V, V}_{GS} = \pm 20 \text{ V}$		-	1.5	^
Gate-Source Leakage	I _{GSS}		1	-	-	± 100	nA
Zero Gate Voltage Drain Current		V _{GS} = 0 V	V _{DS} = 30 V	-	-	1	μΑ
	I _{DSS}	V _{GS} = 0 V	V _{DS} = 30 V, T _J = 125 °C	-	-	50	
		V _{GS} = 0 V	V _{DS} = 30 V, T _J = 175 °C	-	-	150	
On-State Drain Current ^a	I _{D(on)}	V _{GS} = 10 V	V _{DS} ≥ 5 V	10	-	-	Α
		V _{GS} = 10 V	I _D = 6 A	-	0.019	-	Ω
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}$	I _D = 4.9 A	-	0.021	ı	
Drain Gource on Gtate Nesistance	1 103(011)	$V_{GS} = 10 \text{ V}$	I _D = 6 A, T _J = 125 °C	-	0.054	-	
		$V_{GS} = 10 \text{ V}$	I _D = 6 A, T _J = 175 °C	-	0.064	ı	
Forward Transconductance ^b	9fs	$V_{DS} = 15 \text{ V}, I_{D} = 5 \text{ A}$		-	21	ı	S
Dynamic ^b							
Input Capacitance	C _{iss}			-	295	-	
Output Capacitance	C _{oss}	V _{GS} = 0 V	$V_{GS} = 0 V$ $V_{DS} = 15 V, f = 1 MHz$	-	67	-	pF
Reverse Transfer Capacitance	C _{rss}			-	25	-	
Total Gate Charge ^c	Qg			-	6	-	
Gate-Source Charge ^c	Q _{gs}	V _{GS} = 10 V	$V_{DS} = 15 \text{ V}, I_{D} = 6 \text{ A}$	-	1.2	1	nC
Gate-Drain Charge ^c	Q _{gd}	1		-	1	1	
Gate Resistance	R_g	f = 1 MHz		3.0	6.65	11	Ω
Turn-On Delay Time ^c	t _{d(on)}				6	9	
Rise Time ^c	t _r	V_{DD} = 15 V, R_L = 2.5 Ω $I_D\cong 6$ A, V_{GEN} = 10 V, R_g = 1 Ω		=	12	18	ns
Turn-Off Delay Time ^c	t _{d(off)}			=	13	20	
Fall Time ^c	t _f	1		=	8	12	1
Source-Drain Diode Ratings and Char	acteristics ^b						
Pulsed Current ^a	I _{SM}	T		-	-	31	Α
Forward Voltage	V _{SD}	l _E =	= 3 A, V _{GS} = 0 V	-	0.8	1.1	V

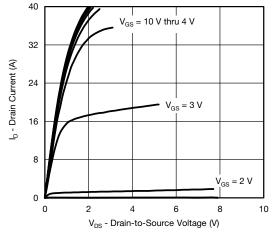
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

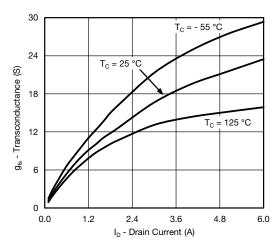
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



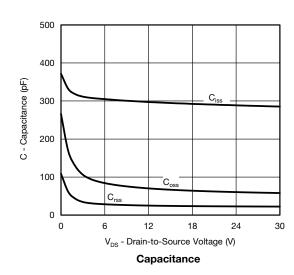
TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)

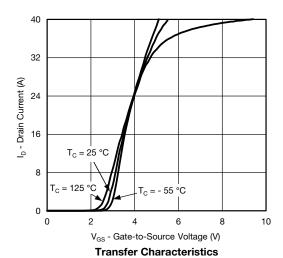


Output Characteristics



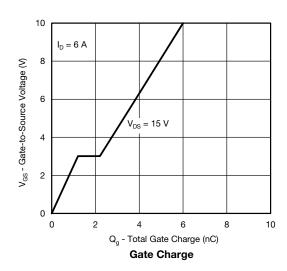
Transconductance





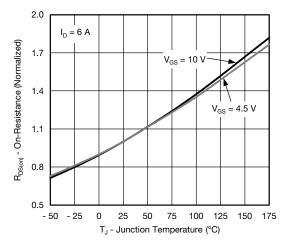
0.10 0.08 0.06 0.04 0.02 0.00

On-Resistance vs. Drain Current

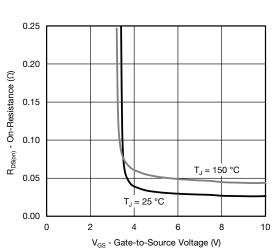




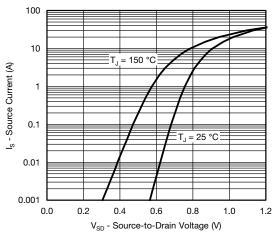
TYPICAL CHARACTERISTICS ($T_A = 25$ °C, unless otherwise noted)



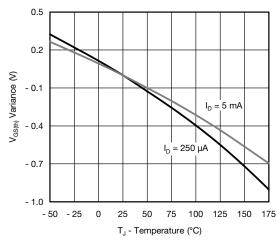
On-Resistance vs. Junction Temperature



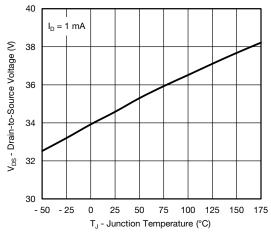
On-Resistance vs. Gate-to-Source Voltage



Source-Drain Diode Forward Voltage



Threshold Voltage

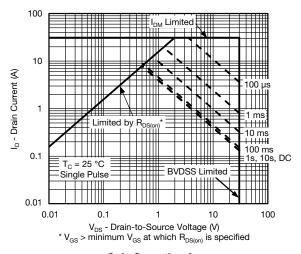


Drain Source Breakdown vs. Junction Temperature

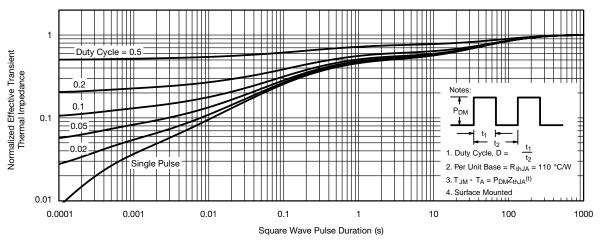


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THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



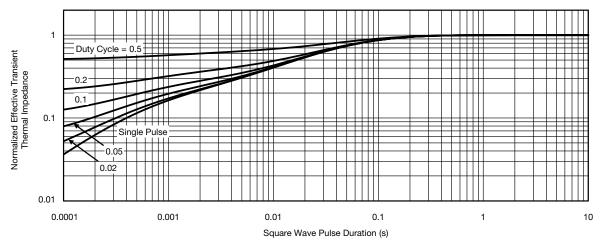
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Foot

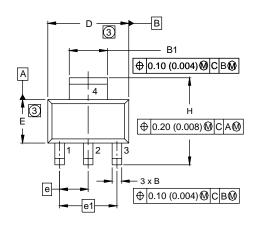
Note

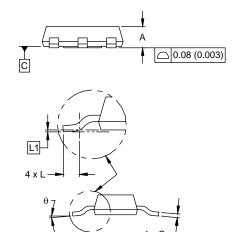
- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction-to-Foot (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



SOT-223 (HIGH VOLTAGE)





DIM.	MILLII	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.		
Α	1.55	1.80	0.061	0.071		
В	0.65	0.85	0.026	0.033		
B1	2.95	3.15	0.116	0.124		
С	0.25	0.35	0.010	0.014		
D	6.30	6.70	0.248	0.264		
E	3.30	3.70	0.130	0.146		
е	2.30 BSC		0.0905 BSC			
e1	4.60 BSC		0.181	BSC		
Н	6.71	7.29	0.264	0.287		
L	0.91	-	0.036	-		
L1	0.061 BSC		0.0024 BSC			
θ	-	10'	-	10'		

ECN: S-82109-Rev. A, 15-Sep-08

DWG: 5969

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).
- 3. Dimension do not include mold flash.
- 4. Outline conforms to JEDEC outline TO-261AA.



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